



CUSTOMER NUMBER 25268

INFORMATION DISCLOSURE STATEMENT LISTING SHEET

Information Cited By Applicant(s) That May Be Material To
The Prosecution Of The Subject Application

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicants: Schwalbe et al Attorney Docket No. CELL0034
Serial No.: 10/824,186 Group Art Unit: 1784
Filed: April 14, 2004 Examiner:
Title: SYSTEM AND METHOD FOR DETERMINING OPTIMAL REACTION PARAMETERS USING CONTINUOUSLY RUNNING PROCESS

INFORMATION DISCLOSURE STATEMENT

U.S. PATENT DOCUMENTS

*Examiner <u>Initial</u>	ID	Document No.	Date	Inventor Name(s)	Class	Sub-Class
<u>M.L.</u>	US1	3,881,701	5/6/1975	Schoenman et al.	259	4
	US2	4,222,671	9/16/1980	Gilmore	366	337
	US3	4,728,502	3/1/1988	Hamill	422	116
	US4	5,209,906	5/11/1993	Watkins et al.	422	200
	US5	5,534,328	7/9/1996	Ashmead et al.	428	166
	US6	5,580,523	12/3/1996	Bard	422	50
	US7	5,595,712	1/21/1997	Harbster et al.	422	129
	US8	5,641,400	6/24/1997	Kaltenbach et al.	210	198
	US9	5,690,763	11/25/1997	Ashmead et al.	156	60
	US10	5,741,466	4/21/1998	Bodnaras	422	228
	US11	5,811,062	9/22/1998	Wegeng et al.	422	129
	US12	5,928,880	7/27/1999	Wilding et al.	435	7.21
	US13	5,961,932	10/5/1999	Ghosh et al.	422	193
	US14	5,976,472	11/2/1999	Chatterjee et al.	422	130
	US15	5,499,650	3/19/1996	McArthur et al.	137	85
	US16	5,698,485	12/16/1997	Brück et al.	501	87
	US17	5,803,600	9/8/1998	Schubert et al.	366	144
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	US19	6,126,723	10/3/2000	Drost et al.	96	4
	US20	6,171,865	1/9/2001	Weigl et al	436	52
<u>M.L.</u>	US21	6,180,081	1/30/2001	Poschmann et al.	423	648.
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*Examiner <u>Initial</u>	<u>ID</u>	<u>Document No.</u>	<u>Date</u>	<u>Inventor Name(s)</u>	<u>Class</u>	<u>Sub-Class</u>
<u>N.L.</u>	US22	6,190,034	2/20/2001	Nielsen et al.	366	336
<u>N.L.</u>	US23	6,192,596	2/27/2001	Bennett et al.	34	76
<u>N.L.</u>	US24	6,221,226	4/24/2001	Kopf-Sill	204	602
<u>N.L.</u>	US25	6,264,900	7/24/2001	Schubert et al.	422	224
<u>N.L.</u>	US26	4,894,146	01/1990	Gidding, John C.	209	12.2
<u>N.L.</u>	US27	6,537,506	03/2003	Schwalbe et al.	422	130
<u>N.L.</u>	US28	US2002/008 0563	06/27/2001	Pence et al.	361	676

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*Examiner <u>Initial</u>	<u>ID</u>	<u>Document No.</u>	<u>Publication Date</u>	<u>Country</u>	<u>Class</u>	<u>Sub-Class</u>	<u>Translation?</u>
<u>N.L.</u>	F1	WO 00/62914	10/26/2000	DE	B01F	3/08	Yes
<u>N.L.</u>	F2	WO 00/34728	06/15/2000	GB	F28D	9/00	

OTHER INFORMATION

NONE CITED

[Signature]
Examiner's Signature

12/28/2004
Date

*Examiner: Initial if reference considered, whether or not citation is in conformance with M.P.E.P. § 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Irg
9/16/04